

Notice of References Cited	Application/Control No. 10/735,342		Applicant(s)/Patent Under Reexamination SHEI ET AL.	
	Examiner Shambhavi Patel		Art Unit 2128	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0074178	04-2003	Sample et al.	703/25
*	B	US-6,275,499	08-2001	Wynn et al.	370/438
*	C	US-6,034,538	03-2000	Abramovici, Miron	326/38
*	D	US-6,539,438	03-2003	Ledzius et al.	710/8
*	E	US-5,907,697	05-1999	Barbier et al.	716/16
*	F	US-2001/0010036	07-2001	Stewart et al.	703/23
*	G	US-6,604,230	08-2003	Khalid et al.	716/16
*	H	US-5,671,432	09-1997	Bertolet et al.	712/11
*	I	US-4,974,226	11-1990	Fujimori et al.	714/726
*	J	US-6,651,225	11-2003	Lin et al.	716/4
*	K	US-6,754,763	06-2004	Lin, Sharon Sheau-Pyng	710/317
*	L	US-6,832,185	12-2004	Musselman et al.	703/23
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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